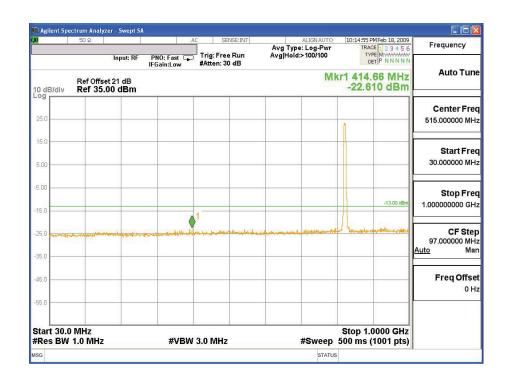




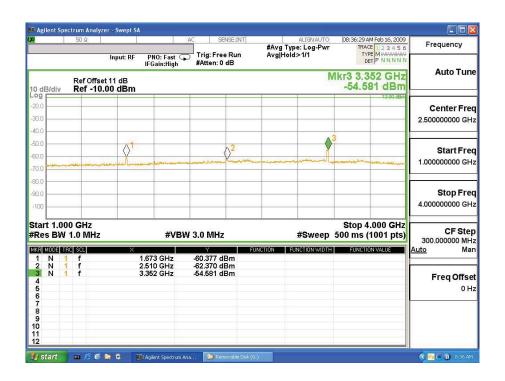
Product	HSUPA PCI Express mini card module			
Test Mode	Spurious Emission (Conducted)			
Date of Test	2009/02/18 Test Site CTR			
Test Condition	WCDMA BAND V HSUPA	Test Range	30MHz~20GHz	

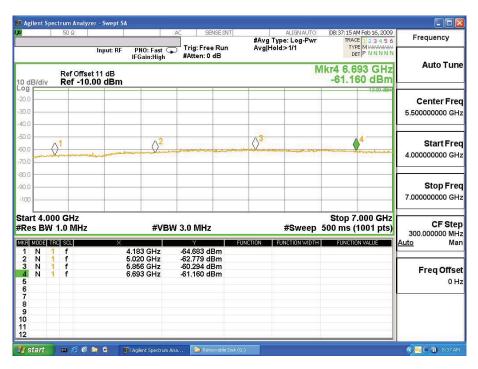
WCDMA BAND V HSUPA Mid-Channel 4183

Frequency	Reading Level	Path Loss	Emission Level	Limit
(MHz)	(dBm)	(dB)	(dBm)	(dBm)
1673.2	-60.38	0.58	-59.80	-13
2509.8	-62.37	0.7	-61.67	-13
3346.4	-54.58	1.01	-53.57	-13
4183	-64.68	1.18	-63.50	-13
5019.6	-62.78	1.23	-61.55	-13
5856.2	-60.29	1.45	-58.84	-13
6692.8	-61.16	1.56	-59.60	-13
7529.4	-63.91	1.59	-62.32	-13
8366	-65.84	1.82	-64.02	-13

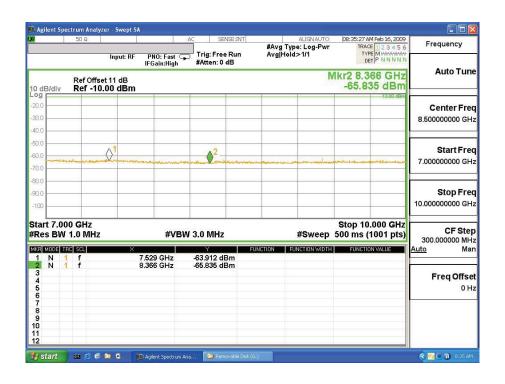










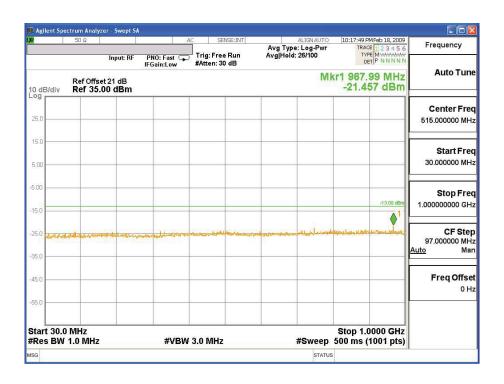




Product	HSUPA PCI Express mini card module			
Test Mode	Spurious Emission (Conducted)			
Date of Test	2009/02/18 Test Site CTR			
Test Condition	WCDMA BAND II	Test Range	30MHz~20GHz	

WCDMA BAND II Mid-Channel 9400

Frequency	Reading Level	Path Loss	Emission Level	Limit
(MHz)	(dBm)	(dB)	(dBm)	(dBm)
3760	-50.66	1.1	-49.56	-13
5640	-57.68	1.23	-56.45	-13
7520	-63.24	1.59	-61.65	-13
9400	-64.31	1.89	-62.42	-13
11280	-60.49	2.07	-58.42	-13
13160	-64.28	2.26	-62.02	-13
15040	-61.10	2.64	-58.46	-13
16920	-60.38	3.5	-56.88	-13
18800	-59.75	3.7	-56.05	-13



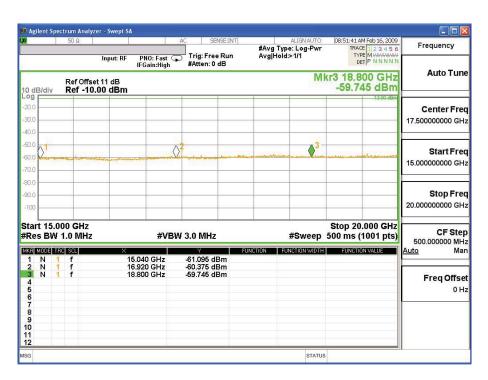










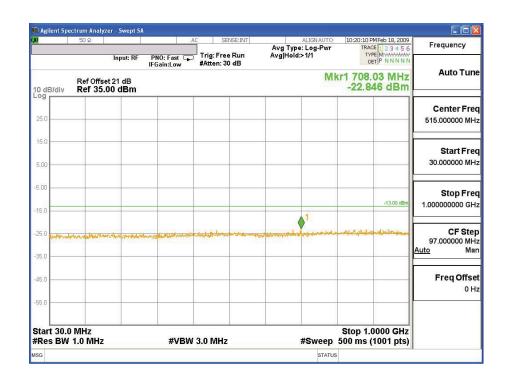




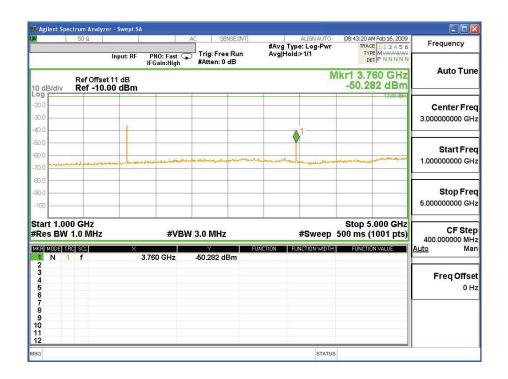
Product	HSUPA PCI Express mini card module			
Test Mode	Spurious Emission (Conducted)			
Date of Test	2009/02/18 Test Site CTR			
Test Condition	WCDMA BAND II HSDPA	Test Range	30MHz~20GHz	

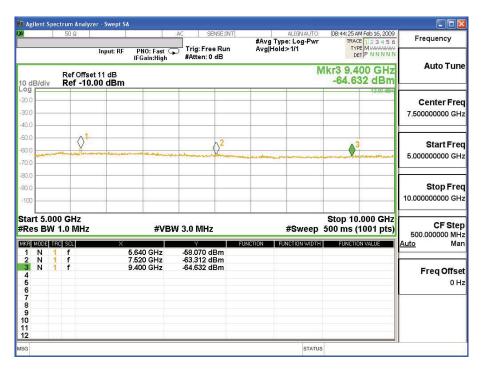
WCDMA BAND II HSDPA Mid-Channel 9400

Frequency	Reading Level	Path Loss	Emission Level	Limit
(MHz)	(dBm)	(dB)	(dBm)	(dBm)
3760	-50.28	1.1	-49.18	-13
5640	-58.07	1.23	-56.84	-13
7520	-63.31	1.59	-61.72	-13
9400	-64.63	1.89	-62.74	-13
11280	-60.58	2.07	-58.51	-13
13160	-63.67	2.26	-61.41	-13
15040	-60.95	2.64	-58.31	-13
16920	-60.82	3.5	-57.32	-13
18800	-59.99	3.7	-56.29	-13

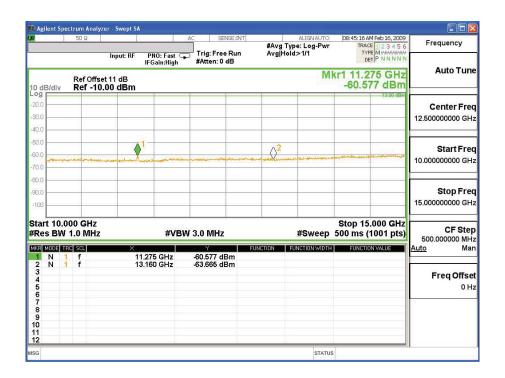


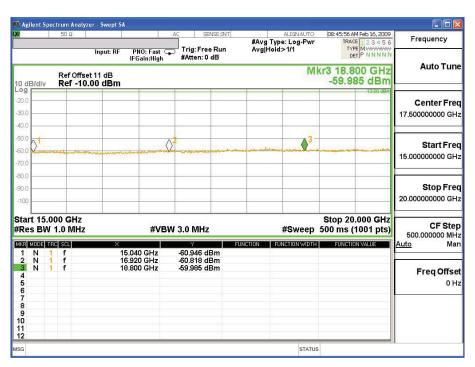










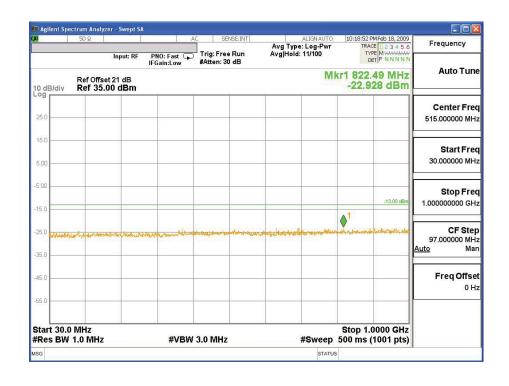




Product	HSUPA PCI Express mini card module				
Test Mode	Spurious Emission (Conducted)				
Date of Test	2009/02/18 Test Site CTR				
Test Condition	WCDMA BAND II HSUPA	Test Range	30MHz~20GHz		

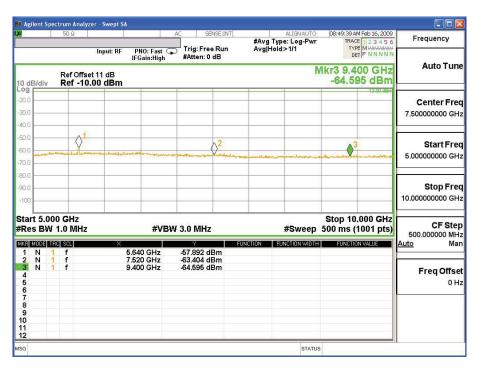
WCDMA BAND II HSUPA Mid-Channel 9400

Frequency	Reading Level	Path Loss	Emission Level	Limit
(MHz)	(dBm)	(dB)	(dBm)	(dBm)
3760	-50.25	1.1	-49.15	-13
5640	-57.89	1.23	-56.66	-13
7520	-63.40	1.59	-61.81	-13
9400	-64.60	1.89	-62.71	-13
11280	-62.44	2.07	-60.37	-13
13160	-61.65	2.26	-59.39	-13
15040	-61.23	2.64	-58.59	-13
16920	-60.15	3.5	-56.65	-13
18800	-58.75	3.7	-55.05	-13

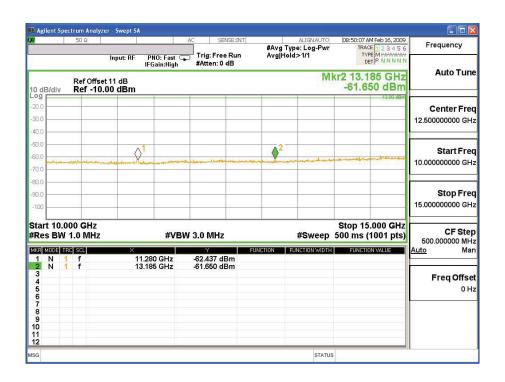


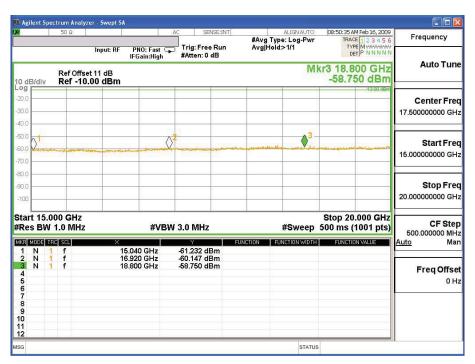














Product	HSUPA PCI Express mini card module				
Test Mode	Spurious Emission (Radiated)				
Date of Test	2009/02/18	Test Site	OATS 3		
Test Condition	Channel 189 (GSM 850 GPRS)	Test Range	30MHz~20GHz		

Frequency	Reading Level	Signal Generator Level	Cable Loss	Antenna Gain	EIRP Value	Limit
(GHz)	(dBm)	(dBm)	(dB)	(dBi)	(dBm)	(dBm)

1672.8	-48	-48.44	1.41	9.8	-40.05	-13
2509.2	-54.79	-53.98	1.56	10.6	-44.94	-13
3345.6	-57.7	-57.48	2.01	12.3	-47.19	-13
4182	-56.98	-52.78	2.74	12.6	-42.92	-13
5018.4	-60.94	-56.65	2.64	12.7	-46.59	-13
5854.8	-56.56	-47.21	2.36	13	-36.57	-13
6691.2	-61.88	-55.62	3.16	12.1	-46.68	-13
7527.6	-62.65	-53.22	3.3	11.5	-45.02	-13
8364	-61.82	-51.21	3.16	11.5	-42.87	-13

Vertical Emissions

1672.8	-44.82	-44.91	1.41	9.8	-36.52	-13
2509.2	-59.9	-61.69	1.56	10.6	-52.65	-13
3345.6	-55.81	-54.62	2.01	12.3	-44.33	-13
4182	-58.48	-55.91	2.74	12.6	-46.05	-13
5018.4	-54.01	-44.93	2.64	12.7	-34.87	-13
5854.8	-59.36	-52.18	2.36	13	-41.54	-13
6691.2	-55.85	-44.75	3.16	12.1	-35.81	-13
7527.6	-55.29	-39.52	3.3	11.5	-31.32	-13
8364	-57.75	-44.81	3.16	11.5	-36.47	-13

- 1. Receiver setting (Peak Detector): RBW:3MHz; VBW:3MHz
- 2. EIRP Value = Signal Generator Level + Antenna Gain Cable Loss



Product	HSUPA PCI Express mini card module		
Test Mode	Spurious Emission (Radiated)		
Date of Test	2009/02/18	Test Site	OATS 3
Test Condition	Channel 661 (PCS1900 GPRS)	Test Range	30MHz~20GHz

Frequency	Reading Level	Signal Generator Level	Cable Loss	Antenna Gain	EIRP Value	Limit
(GHz)	(dBm)	(dBm)	(dB)	(dBi)	(dBm)	(dBm)

3760	-54.610	-56.260	1.41	12.6	-45.070	-13
5640	-51.640	-48.634	1.56	13.1	-37.094	-13
7520	-51.440	-42.080	2.01	11.5	-32.590	-13
9400	-61.020	-46.103	2.74	12	-36.843	-13
11280	-64.880	-51.682	2.64	12	-42.322	-13
13160	-63.240	-50.758	2.36	13.3	-39.818	-13

Vertical Emissions

3760	-48.470	-50.402	1.41	12.6	-39.212	-13
5640	-47.050	-44.470	1.56	13.1	-32.930	-13
7520	-50.810	-41.754	2.01	11.5	-32.264	-13
9400	-61.270	-46.378	2.74	12	-37.118	-13
11280	-63.580	-50.848	2.64	12	-41.488	-13
13160	-63.760	-51.576	2.36	13.3	-40.636	-13

- 1. Receiver setting (Peak Detector): RBW:3MHz; VBW:3MHz
- 2. EIRP Value = Signal Generator Level + Antenna Gain Cable Loss
- 3. Spurious emissions past 12GHz are not shown, due to the magnitude of spurious emissions attenuated more than 20 dB below the limit.



Product	HSUPA PCI Express mini card module		
Test Mode	Spurious Emission (Radiated)		
Date of Test	2009/02/18	Test Site	OATS 3
Test Condition	Channel 189 (GSM 850 EGPRS)	Test Range	30MHz~20GHz

Frequency	Reading Level	Signal Generator Level	Cable Loss	Antenna Gain	EIRP Value	Limit
(GHz)	(dBm)	(dBm)	(dB)	(dBi)	(dBm)	(dBm)

1672.8	-52.9	-55.49	1.41	9.8	-47.10	-13
2509.2	-59.57	-61.73	1.56	10.6	-52.69	-13
3345.6	-59.6	-60.61	2.01	12.3	-50.32	-13
4182	-60.8	-60.16	2.74	12.6	-50.30	-13
5018.4	-61.39	-57.50	2.64	12.7	-47.44	-13
5854.8	-60.72	-55.16	2.36	13	-44.52	-13
6691.2	-60.86	-53.43	3.16	12.1	-44.49	-13
7527.6	-62.44	-52.76	3.3	11.5	-44.56	-13
8364	-60.28	-48.44	3.16	11.5	-40.10	-13

Vertical Emissions

voicioui Eiiiic	010110					
1672.8	-47.9	-48.72	1.41	9.8	-40.33	-13
2509.2	-60.14	-61.94	1.56	10.6	-52.90	-13
3345.6	-57.91	-58.36	2.01	12.3	-48.07	-13
4182	-59.38	-57.61	2.74	12.6	-47.75	-13
5018.4	-57.63	-50.04	2.64	12.7	-39.98	-13
5854.8	-60.29	-53.76	2.36	13	-43.12	-13
6691.2	-59.42	-50.00	3.16	12.1	-41.06	-13
7527.6	-58.98	-46.84	3.3	11.5	-38.64	-13
8364	-57.56	-44.52	3.16	11.5	-36.18	-13

- 1. Receiver setting (Peak Detector) : RBW:3MHz; VBW:3MHz
- 2. EIRP Value = Signal Generator Level + Antenna Gain Cable Loss



Product	HSUPA PCI Express mini card module		
Test Mode	Spurious Emission (Radiated)		
Date of Test	2009/02/18	Test Site	OATS 3
Test Condition	Channel 661 (PCS1900 EGPRS)	Test Range	30MHz~20GHz

Frequency	Reading Level	Signal Generator Level	Cable Loss	Antenna Gain	EIRP Value	Limit
(GHz)	(dBm)	(dBm)	(dB)	(dBi)	(dBm)	(dBm)

3760	-56.940	-58.872	1.41	9.8	-47.682	-13
5640	-53.420	-50.840	1.56	10.6	-39.300	-13
7520	-56.270	-47.214	2.01	12.3	-37.724	-13
9400	-61.490	-46.598	2.74	12.6	-37.338	-13
11280	-62.730	-49.998	2.64	12.7	-40.638	-13

Vertical Emissions

3760	-48.690	-50.622	1.41	9.8	-39.432	-13
5640	-47.960	-45.380	1.56	10.6	-33.840	-13
7520	-57.300	-48.244	2.01	12.3	-38.754	-13
9400	-62.570	-47.678	2.74	12.6	-38.418	-13
11280	-63.870	-51.138	2.64	12.7	-41.778	-13

- 1. Receiver setting (Peak Detector): RBW:3MHz; VBW:3MHz
- 2. EIRP Value = Signal Generator Level + Antenna Gain Cable Loss
- 3. Spurious emissions past 12GHz are not shown, due to the magnitude of spurious emissions attenuated more than 20 dB below the limit.



Product	HSUPA PCI Express mini card module		
Test Mode	Spurious Emission (Radiated)		
Date of Test	2009/02/18	Test Site	OATS 3
Test Condition	Channel 4183 (WCDMA BAND V)	Test Range	30MHz~20GHz

Frequency	Reading Level	Signal Generator Level	Cable Loss	Antenna Gain	EIRP Value	Limit
(GHz)	(dBm)	(dBm)	(dB)	(dBi)	(dBm)	(dBm)

1762	-51.97	-54.06	1.41	9.8	-45.67	-13
2644	-57.84	-59.24	1.56	10.6	-50.20	-13
3345.6	-58.68	-59.23	2.01	12.3	-48.94	-13
4182	-59.00	-56.33	2.74	12.6	-46.47	-13
5018.4	-61.96	-58.58	2.64	12.7	-48.52	-13
5854.8	-61.44	-56.81	2.36	13	-46.17	-13
6691.2	-61.78	-55.29	3.16	12.1	-46.35	-13
7527.6	-63.20	-54.44	3.3	11.5	-46.24	-13
8364	-63.21	-53.44	3.16	11.5	-45.10	-13

Vertical Emissions

1763.2	-48.69	-49.70	1.41	9.8	-41.31	-13
2641.8	-55.95	-56.22	1.56	10.6	-47.18	-13
3346.4	-56.73	-56.20	2.01	12.3	-45.91	-13
4182	-59.65	-58.13	2.74	12.6	-48.27	-13
5018.4	-60.4	-55.77	2.64	12.7	-45.71	-13
5854.8	-60.3	-53.78	2.36	13	-43.14	-13
6691.2	-61.6	-59.26	3.16	12.1	-50.32	-13
7527.6	-63.17	-60.77	3.3	11.5	-52.57	-13
8364	-62.79	-57.14	3.16	11.5	-48.80	-13

- 1. Receiver setting (Peak Detector): RBW:3MHz; VBW:3MHz
- 2. EIRP Value = Signal Generator Level + Antenna Gain Cable Loss



Product	HSUPA PCI Express mini card module					
Test Mode	Spurious Emission (Radiated)					
Date of Test	2009/02/18	Test Site	OATS 3			
Test Condition	Channel 4183 (WCDMA BAND V HSDPA)	Test Range	30MHz~20GHz			

Frequency	Reading Level	Signal Generator Level	Cable Loss	Antenna Gain	EIRP Value	Limit
(GHz)	(dBm)	(dBm)	(dB)	(dBi)	(dBm)	(dBm)

1763.2	-50.62	-52.03	1.41	9.8	-43.64	-13
2641.8	-46.25	-42.73	1.56	10.6	-33.69	-13
3346.4	-59.97	-61.08	2.01	12.3	-50.79	-13
4182	-59.3	-56.98	2.74	12.6	-47.12	-13
5018.4	-61.01	-56.78	2.64	12.7	-46.72	-13
5854.8	-61.52	-57.00	2.36	13	-46.36	-13
6691.2	-60.97	-53.64	3.16	12.1	-44.70	-13
7527.6	-62.73	-53.40	3.3	11.5	-45.20	-13
8364	-62.42	-52.17	3.16	11.5	-43.83	-13

Vertical Emissions

1763.2	-34.56	-33.62	1.41	9.8	-25.23	-13
2644	-35.57	-31.23	1.56	10.6	-22.19	-13
3526	-55.54	-54.23	2.01	12.3	-43.94	-13
4182	-60.2	-59.17	2.74	12.6	-49.31	-13
5018.4	-60.94	-57.05	2.64	12.7	-46.99	-13
5854.8	-60.59	-54.27	2.36	13	-43.63	-13
6691.2	-61.56	-59.12	3.16	12.1	-50.18	-13
7527.6	-63.07	-60.52	3.3	11.5	-52.32	-13
8364	-62.98	-57.65	3.16	11.5	-49.31	-13

- 1. Receiver setting (Peak Detector) : RBW:3MHz; VBW:3MHz
- 2. EIRP Value = Signal Generator Level + Antenna Gain Cable Loss



Product	HSUPA PCI Express mini card module					
Test Mode	Spurious Emission (Radiated)					
Date of Test	2009/02/18 Test Site OATS 3					
Test Condition	Channel 4183 (WCDMA BAND V HSUPA) Test Range 30MHz~20GHz					

Frequency	Reading Level	Signal Generator Level	Cable Loss	Antenna Gain	EIRP Value	Limit
(GHz)	(dBm)	(dBm)	(dB)	(dBi)	(dBm)	(dBm)

1763.2	-45.42	-45.29	1.41	9.8	-36.90	-13
2641.8	-41.42	-37.29	1.56	10.6	-28.25	-13
3346.4	-60.06	-61.19	2.01	12.3	-50.90	-13
4182	-60.4	-59.35	2.74	12.6	-49.49	-13
5018.4	-62.19	-59.02	2.64	12.7	-48.96	-13
5854.8	-61.63	-57.25	2.36	13	-46.61	-13
6691.2	-60.68	-53.09	3.16	12.1	-44.15	-13
7527.6	-62.72	-53.38	3.3	11.5	-45.18	-13
8364	-62.12	-51.69	3.16	11.5	-43.35	-13

Vertical Emissions

1763.2	-40.29	-39.67	1.41	9.8	-31.28	-13
2641.8	-32.36	-27.91	1.56	10.6	-18.87	-13
3526	-55.5	-54.17	2.01	12.3	-43.88	-13
4182	-59.51	-57.86	2.74	12.6	-48.00	-13
5018.4	-61.03	-57.26	2.64	12.7	-47.20	-13
5854.8	-59.91	-53.12	2.36	13	-42.48	-13
6691.2	-61.2	-57.83	3.16	12.1	-48.89	-13
7527.6	-62.13	-54.59	3.3	11.5	-46.39	-13
8364	-62.7	-56.90	3.16	11.5	-48.56	-13

- 1. Receiver setting (Peak Detector) : RBW:3MHz; VBW:3MHz
- 2. EIRP Value = Signal Generator Level + Antenna Gain Cable Loss



Product	HSUPA PCI Express mini card module			
Test Mode	Spurious Emission (Radiated)			
Date of Test	2009/02/18	Test Site	OATS 3	
Test Condition	Channel 9400 (WCDMA BAND II)	Test Range	30MHz~20GHz	

Frequency	Reading Level	Signal Generator Level	Cable Loss	Antenna Gain	EIRP Value	Limit
(GHz)	(dBm)	(dBm)	(dB)	(dBi)	(dBm)	(dBm)

3760	-56.750	-58.400	1.41	12.6	-47.210	-13
5640	-62.250	-59.244	1.56	13.1	-47.704	-13
7520	-62.650	-53.290	2.01	11.5	-43.800	-13
9400	-64.010	-49.093	2.74	12	-39.833	-13
11280	-63.710	-50.512	2.64	12	-41.152	-13

Vertical Emissions

3760	-51.660	-53.592	1.41	12.6	-42.402	-13
5640	-61.680	-59.100	1.56	13.1	-47.560	-13
7520	-60.420	-51.364	2.01	11.5	-41.874	-13
9400	-59.870	-44.978	2.74	12	-35.718	-13
11280	-61.410	-48.678	2.64	12	-39.318	-13

- 1. Receiver setting (Peak Detector): RBW:3MHz; VBW:3MHz
- 2. EIRP Value = Signal Generator Level + Antenna Gain Cable Loss
- 3. Spurious emissions past 12GHz are not shown, due to the magnitude of spurious emissions attenuated more than 20 dB below the limit.



Product	HSUPA PCI Express mini card module			
Test Mode	Spurious Emission (Radiated)			
Date of Test	2009/02/18	Test Site	OATS 3	
Test Condition	Channel 9400 (WCDMA BAND II HSDPA)	Test Range	30MHz~20GHz	

Frequency	Reading Level	Signal Generator Level	Cable Loss	Antenna Gain	EIRP Value	Limit
(GHz)	(dBm)	(dBm)	(dB)	(dBi)	(dBm)	(dBm)

3760	-55.930	-57.580	1.41	12.6	-46.390	-13
5640	-62.460	-59.454	1.56	13.1	-47.914	-13
7520	-63.260	-53.900	2.01	11.5	-44.410	-13
9400	-63.600	-48.683	2.74	12	-39.423	-13
11280	-64.050	-50.852	2.64	12	-41.492	-13

Vertical Emissions

3760	-52.130	-54.062	1.41	12.6	-42.872	-13
5640	-61.210	-58.630	1.56	13.1	-47.090	-13
7520	-61.310	-52.254	2.01	11.5	-42.764	-13
9400	-59.910	-45.018	2.74	12	-35.758	-13
11280	-62.420	-49.688	2.64	12	-40.328	-13

- 1. Receiver setting (Peak Detector): RBW:3MHz; VBW:3MHz
- 2. EIRP Value = Signal Generator Level + Antenna Gain Cable Loss
- 3. Spurious emissions past 12GHz are not shown, due to the magnitude of spurious emissions attenuated more than 20 dB below the limit.



Product	HSUPA PCI Express mini card module				
Test Mode	Spurious Emission (Radiated)				
Date of Test	2009/02/18	Test Site	OATS 3		
Test Condition	Channel 9400 (WCDMA BAND II HSUPA)	Test Range	30MHz~20GHz		

Frequency	Reading Level	Signal Generator Level	Cable Loss	Antenna Gain	EIRP Value	Limit
(GHz)	(dBm)	(dBm)	(dB)	(dBi)	(dBm)	(dBm)

3760	-56.200	-57.850	1.41	12.6	-46.660	-13
5640	-62.620	-59.614	1.56	13.1	-48.074	-13
7520	-62.620	-53.260	2.01	11.5	-43.770	-13
9400	-64.170	-49.253	2.74	12	-39.993	-13
11280	-62.940	-49.742	2.64	12	-40.382	-13

Vertical Emissions

3760	-51.950	-53.882	1.41	12.6	-42.692	-13
5640	-62.090	-59.510	1.56	13.1	-47.970	-13
7520	-60.760	-51.704	2.01	11.5	-42.214	-13
9400	-60.080	-45.188	2.74	12	-35.928	-13
11280	-58.900	-46.168	2.64	12	-36.808	-13

- 1. Receiver setting (Peak Detector): RBW:3MHz; VBW:3MHz
- 2. EIRP Value = Signal Generator Level + Antenna Gain Cable Loss
- 3. Spurious emissions past 12GHz are not shown, due to the magnitude of spurious emissions attenuated more than 20 dB below the limit.



6. Frequency Stability Under Temperature & Voltage Variations

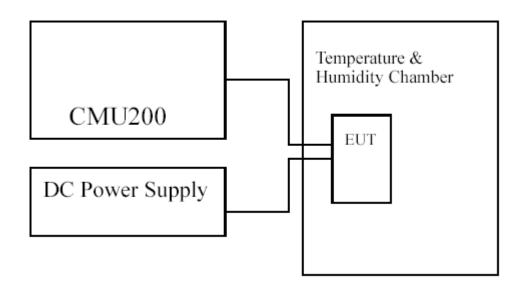
6.1. Test Equipment

The following test equipments are used during the frequency stability test:

Equipment	Manufacturer	Model No./Serial No.	Last Cal.
Universal Radio Communication Tester	R&S	CMU200 / 104846	Apr., 2008
Standard Temperature & Humidity Chamber	WIT	TH-1S-B / 108210	Aug., 2008
DC Power Supply	Topward	6303D / 670302	N/A

Note: All equipments upon which need to be calibrated are with calibration period of 1 year

6.2. Test Setup



6.3. Limits

Limit	< <u>+</u> 2.5ppm



6.4. Test Procedure

The frequency stability of transmitter is measured by:

- (a) Temperature: The temperature is varied from -30°C to 50°C in 10°C increament using a standard temperature & Humidity chamber.
- (b) Primary Supply Voltage: The primary supply voltage is varied 85% to 115% of the nominal value for non hand-carried equipment. For hand-carried, battery-powered equipment, primary supply voltage is reduced to the battery operating endpoint which shall be specified by the manufacturer.

The EUT was connected via the base station simulator. Universal Radio Communication Tester, (CMU200), was used to measure The Frequency Error. The maximum result of measurements was recorded.

6.5. Test Specification

According to Part 2.1055,22.355,24.235



6.6. Test Result of Frequency Stability Under Temperature Variations

Product	HSUPA PCI Express mini card module			
Test Mode	Frequency Stability Under Temperature Variations & Voltage Variations			
Date of Test	2009/02/18 Test Site CTR			
Test	GSM 850 GPRS / Channel 189	Test Range	-30°C∼+50°C	
Condition				

Temperature	Test Frequency	Deviation	Limit
	. ,		
Interval(°ℂ)	(GHz)	(Hz)	(KHz)
-30	0.836	-44	±2.09
-20	0.836	-37	±2.09
-10	0.836	24	±2.09
0	0.836	28	±2.09
10	0.836	-29	±2.09
20	0.836	-33	±2.09
30	0.836	-32	±2.09
40	0.836	-36	±2.09
50	0.836	-39	±2.09



.Product	HSUPA PCI Express mini card module			
Test Mode	Frequency Stability Under Temperature Variations & Voltage Variations			
Date of Test	2009/02/18 Test Site CTR			
Test	PCS 1900 GPRS / Channel 661	Test Range	-30°C~+50°C	
Condition				

Temperature	Test Frequency	Deviation	Limit
Interval(°ℂ)	(GHz)	(Hz)	(KHz)
-30	1.88	-82	±4.7
-20	1.88	-74	±4.7
-10	1.88	-31	±4.7
0	1.88	-62	±4.7
10	1.88	-32	±4.7
20	1.88	-58	±4.7
30	1.88	-43	±4.7
40	1.88	-84	±4.7
50	1.88	-43	±4.7



Product	HSUPA PCI Express mini card module			
Test Mode	Frequency Stability Under Temperature Variations & Voltage Variations			
Date of Test	2009/02/18 Test Site CTR			
Test	GSM 850 EGPRS / Channel 189 Test Range -30°C ~+50°C			
Condition				

Temperature	Test Frequency	Deviation	Limit
Interval(°ℂ)	(GHz)	(Hz)	(KHz)
-30	0.836	-44	±2.09
-20	0.836	46	±2.09
-10	0.836	48	±2.09
0	0.836	-35	±2.09
10	0.836	-52	±2.09
20	0.836	-24	±2.09
30	0.836	-37	±2.09
40	0.836	-29	±2.09
50	0.836	-35	±2.09



.Product	HSUPA PCI Express mini card module			
Test Mode	Frequency Stability Under Temperature Variations & Voltage Variations			
Date of Test	2009/02/18 Test Site CTR			
Test	PCS 1900 EGPRS / Channel 661 Test Range -30°C ~+50°C			
Condition			ļ	

Temperature Interval(°C)	Test Frequency (GHz)	Deviation (Hz)	Limit (KHz)
-30	1.88	-64	±4.7
-20	1.88	-61	±4.7
-10	1.88	32	±4.7
0	1.88	-73	±4.7
10	1.88	-59	±4.7
20	1.88	-67	±4.7
30	1.88	-62	±4.7
40	1.88	-67	±4.7
50	1.88	-81	±4.7



Product	HSUPA PCI Express mini card module			
Test Mode	Frequency Stability Under Temperature Variations & Voltage Variations			
Date of Test	2009/02/18 Test Site CTR			
Test	WCDMA BAND V / Channel 4183 Test Range -30°C ~+50°C			
Condition				

Temperature	Test Frequency	Deviation	Limit
Interval(°ℂ)	(GHz)	(Hz)	(KHz)
-30	0.836	18	±2.09
-20	0.836	20	±2.09
-10	0.836	-16	±2.09
0	0.836	-19	±2.09
10	0.836	-23	±2.09
20	0.836	-16	±2.09
30	0.836	14	±2.09
40	0.836	-13	±2.09
50	0.836	-13	±2.09



.Product	HSUPA PCI Express mini card module				
Test Mode	Frequency Stability Under Temperature Variations & Voltage Variations				
Date of Test	2009/02/18 Test Site CTR				
Test	WCDMA BAND V HSDPA / Channel 4183	Test Range	-30°C ~+50°C		
Condition					

Temperature	Test Frequency	Deviation	Limit
Interval(°ℂ)	(GHz)	(Hz)	(KHz)
-30	0.836	17	±2.09
-20	0.836	25	±2.09
-10	0.836	28	±2.09
0	0.836	-19	±2.09
10	0.836	-27	±2.09
20	0.836	-20	±2.09
30	0.836	-17	±2.09
40	0.836	-27	±2.09
50	0.836	-19	±2.09



.Product	HSUPA PCI Express mini card module				
Test Mode	Frequency Stability Under Temperature Variations & Voltage Variations				
Date of Test	2009/02/18 Test Site CTR				
Test	WCDMA BAND V HSUPA / Channel 4183 Test Range -30°C ~+50°				
Condition					

Temperature	Test Frequency	Deviation	Limit
Interval(°ℂ)	(GHz)	(Hz)	(KHz)
-30	0.836	17	±2.09
-20	0.836	26	±2.09
-10	0.836	31	±2.09
0	0.836	22	±2.09
10	0.836	20	±2.09
20	0.836	-24	±2.09
30	0.836	-22	±2.09
40	0.836	-17	±2.09
50	0.836	19	±2.09



Product	HSUPA PCI Express mini card module				
Test Mode	Frequency Stability Under Temperature Variations & Voltage Variations				
Date of Test	2009/02/18 Test Site CTR				
Test	WCDMA BAND II / Channel 9400 Test Range -30°C ~+50°C				
Condition					

Temperature Interval(°C)	Test Frequency (GHz)	Deviation (Hz)	Limit (KHz)
-30	1.88	-46	±4.7
-20	1.88	26	±4.7
-10	1.88	-46	±4.7
0	1.88	-33	±4.7
10	1.88	-26	±4.7
20	1.88	28	±4.7
30	1.88	-41	±4.7
40	1.88	-30	±4.7
50	1.88	29	±4.7



.Product	HSUPA PCI Express mini card module				
Test Mode	Frequency Stability Under Temperature Variations & Voltage Variations				
Date of Test	2009/02/18 Test Site CTR				
Test	VCDMA BAND II HSDPA / Channel 9400 Test Range -30°C ~+50°C				
Condition					

Temperature	Test Frequency	Deviation	Limit
Interval(°C)	(GHz)	(Hz)	(KHz)
-30	1.88	-26	<u>+</u> 4.7
-20	1.88	-29	<u>+</u> 4.7
-10	1.88	-40	<u>±</u> 4.7
0	1.88	-34	<u>±</u> 4.7
10	1.88	-40	<u>±</u> 4.7
20	1.88	-27	<u>±</u> 4.7
30	1.88	34	<u>±</u> 4.7
40	1.88	-26	<u>±</u> 4.7
50	1.88	29	<u>+</u> 4.7



.Product	HSUPA PCI Express mini card module				
Test Mode	Frequency Stability Under Temperature Variations & Voltage Variations				
Date of Test	2009/02/18 Test Site CTR				
Test	VCDMA BAND II HSUPA / Channel 9400 Test Range -30°C ~+50°C				
Condition					

Temperature Interval(°C)	Test Frequency (GHz)	Deviation (Hz)	Limit (KHz)
	, ,	` '	` '
-30	1.88	-31	<u>+</u> 4.7
-20	1.88	-29	<u>+</u> 4.7
-10	1.88	-32	±4.7
0	1.88	38	±4.7
10	1.88	-35	±4.7
20	1.88	33	±4.7
30	1.88	-44	<u>+</u> 4.7
40	1.88	-35	±4.7
50	1.88	28	±4.7



7. EMI Reduction Method During Compliance Testing

No modification was made during testing.

Page: 105 of 107



Attachment 1: EUT Test Photographs

Page: 106 of 107



Attachment 2: EUT Detailed Photographs

Page: 107 of 107